Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/605,914	CHEN, JUNG-FU	
Examiner	Art Unit	
Angel A. Castro	2627	

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SEARCHED			
Class	Subclass	Date	Examiner
720	610		
	609		
	601	6/20/2006	AC

INT	INTERFERENCE SEARCHED		
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